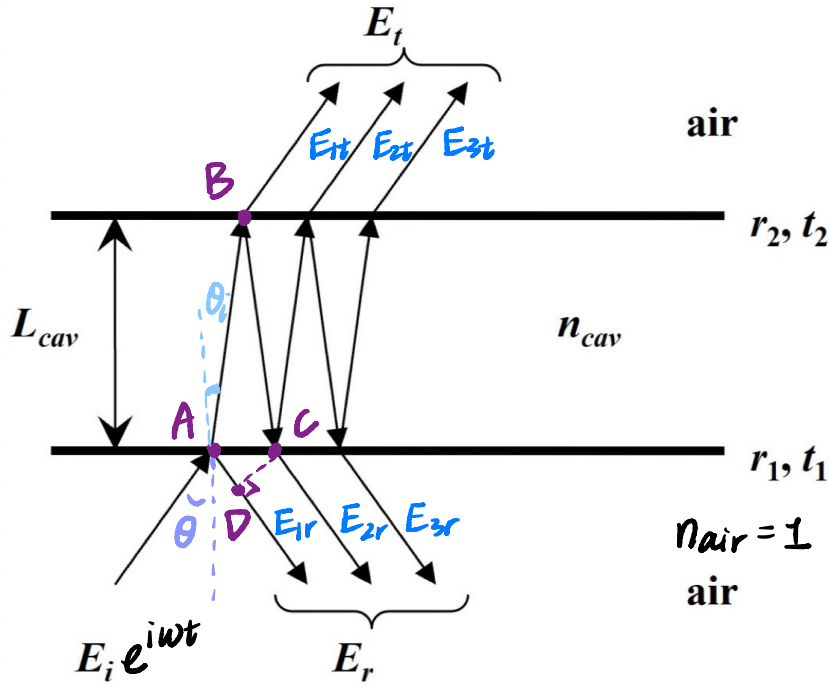


Series 6 - Basic notions on the physics of semiconductor microcavities

1)



We wish to determine the phase shift δ associated with the optical path difference between the first reflected beam and the second one:

$$\Delta = n_{\text{car}}(\overline{AB} + \overline{BC}) - \underbrace{n_{\text{air}} \cdot \overline{AD}}_1 \quad \overline{AB} = \overline{BC} = \frac{L_{\text{car}}}{\cos \theta_i}, \quad \overline{AD} = \underbrace{\overline{AC}}_2 \sin \theta, \\ \text{Snell law: } \sin \theta = n_{\text{car}} \sin \theta_i, \quad \underbrace{\quad}_2 L_{\text{car}} \tan \theta_i$$

$$= 2n_{\text{cav}} L_{\text{cav}} \frac{1}{\cos \theta_i} - 2n_{\text{cav}} L_{\text{cav}} \frac{\sin^2 \theta_i}{\cos \theta_i} = 2n_{\text{cav}} L_{\text{cav}} \cos \theta_i$$

$$\Rightarrow \delta = \frac{2\pi}{\lambda} L \quad (\text{when neglecting dephasing occurring at the reflection})$$

$$\Rightarrow \delta = \frac{2\pi}{\lambda} (2n_{\text{cav}} L_{\text{cav}} \cos \theta_i)$$

2) The transmitted field is related to the incoming one through:

$$E_{tt} = E_i e^{i\omega t} \cdot t_1 \cdot e^{i\delta_0} \cdot t_2 \quad (\delta_0 = \frac{2\pi}{\lambda} n_{\text{cav}} \overline{AB})$$

$$\begin{aligned}
 E_{2t} &= E_i e^{i\omega t} \cdot t_1 \cdot e^{i\delta_0} \cdot (r_2 \cdot r_1 \cdot e^{i\delta}) \cdot t_2 \\
 E_{3t} &= E_i e^{i\omega t} \cdot t_1 \cdot e^{i\delta_0} \cdot (r_2 \cdot r_1 \cdot e^{i\delta})^2 \cdot t_2 \\
 &\vdots \\
 E_{Nt} &= E_i e^{i\omega t} \cdot t_1 \cdot e^{i\delta_0} \cdot (r_2 \cdot r_1 \cdot e^{i\delta})^{N-1} \cdot t_2
 \end{aligned}
 \left. \begin{array}{l} \\ \\ \\ \end{array} \right\} E_t = E_{1t} + E_{2t} + E_{3t} + \dots + E_{Nt}$$

$$\Rightarrow E_t = E_{1t} [1 + r_1 r_2 e^{i\delta} + (r_1 r_2 e^{i\delta})^2 + \dots + (r_1 r_2 e^{i\delta})^{N-1}]$$

(physically $|r_1 r_2 e^{i\delta}| < 1$, provided $N \rightarrow \infty$)

$$E_t = E_{1t} \left[\frac{1}{1 - r_1 r_2 e^{i\delta}} \right] \quad E_{1t} = E_i e^{i(\omega t + \delta_0)} \cdot t_1 t_2$$

geometric series:

$$\sum_{k=0}^{\infty} a r^k \xrightarrow{|r| < 1} \frac{a}{1-r}$$

$$\Rightarrow E_t = E_i e^{i(\omega t + \delta_0)} \left[\frac{t_1 t_2}{1 - r_1 r_2 e^{i\delta}} \right]$$

$$\begin{aligned}
 3) \quad T &= \left| \frac{E_t}{E_i} \right|^2 = \frac{(t_1 t_2)^2}{|1 - r_1 r_2 \cos \delta - i r_1 r_2 \sin \delta|^2} \\
 &\quad (1 - r_1 r_2 \cos \delta)^2 + (r_1 r_2 \sin \delta)^2 = 1 - 2r_1 r_2 \cos \delta + (r_1 r_2)^2 \\
 &\quad = (1 - r_1 r_2)^2 + 2r_1 r_2 \frac{(1 - \cos \delta)}{2 \sin^2 \frac{\delta}{2}}
 \end{aligned}$$

$$\Rightarrow T = \frac{(t_1 t_2)^2}{(1 - r_1 r_2)^2 + 4r_1 r_2 \sin^2 \left(\frac{\delta}{2} \right)} \quad \text{or} \quad \frac{(t_1 t_2)^2}{1 + (r_1 r_2)^2 - 2r_1 r_2 \cos \delta}$$

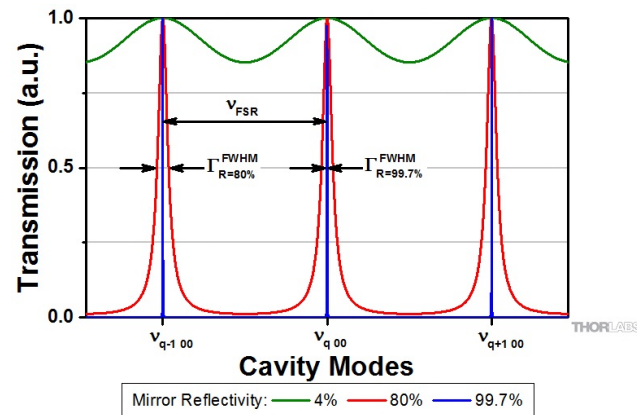
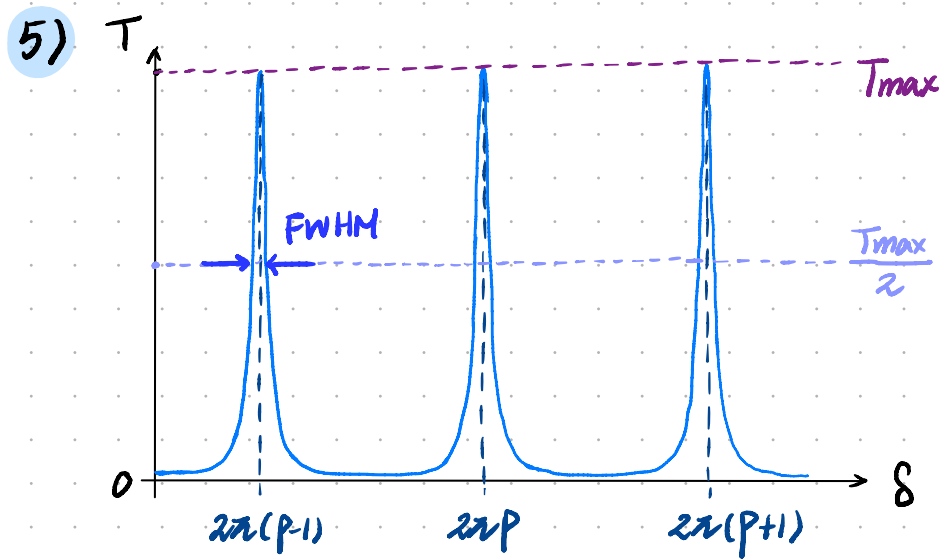
In absence of any optical losses: $R + T = 1$

4) Condition of cavity modes: $\delta = 2\pi p$, $p = \text{integer}$ cavity mode wavelength

$$\Rightarrow \frac{2\pi}{\lambda} (2n_{\text{cav}} L_{\text{cav}} \cos \theta_i) = 2\pi p \Rightarrow 2n_{\text{cav}} L_{\text{cav}} \cos \theta_i = p\lambda \quad \begin{array}{l} \swarrow \text{(associated with } E) \end{array}$$

⊕ phase at the reflection (depends on energy E): $\phi(E)$

$$\Rightarrow 2n_{\text{cav}} L_{\text{cav}} \cos \theta_i = \left(p - \frac{\phi(E)}{2\pi} \right) \lambda$$



The linewidth (FWHM) of the modes γ_c is obtained by determining δ' :

$$T(\delta') = \frac{T_{\text{max}}}{2} \quad \text{with } \delta' = \delta + \varepsilon, \quad \delta = 2\pi p \quad (p = \text{integer}), \quad \varepsilon \ll \delta^*$$

* here, everything is calculated with $T_{\text{min}} \sim 0$, as shown in the fig. on left, which is generally the case for Fabry Perot cavities in reality ($R \sim 1$)

$$T_{\text{max}} = T(\delta) = \frac{(t_1 t_2)^2}{(1 - r_1 r_2)^2}$$

$$\Rightarrow \frac{(t_1 t_2)^2}{2(1 - r_1 r_2)^2} = \frac{(t_1 t_2)^2}{1 + (r_1 r_2)^2 - 2r_1 r_2 \cos \delta'}$$

$$\Rightarrow \cancel{1} + \cancel{2}(r_1 r_2)^2 - 4r_1 r_2 = \cancel{1} + (r_1 r_2)^2 - 2r_1 r_2 \cos \delta' \quad \cos \delta' = \cos(2\pi p + \varepsilon)$$

$$= \cos \varepsilon$$

$$\Rightarrow \cos \varepsilon = - \frac{(1 - r_1 r_2)^2 - 2r_1 r_2}{2r_1 r_2} = 1 - \frac{(1 - r_1 r_2)^2}{2r_1 r_2}$$

$$\varepsilon \ll \delta \Rightarrow 1 - \frac{\varepsilon^2}{2} = 1 - \frac{(1 - r_1 r_2)^2}{2r_1 r_2} \Rightarrow \varepsilon = \frac{1 - r_1 r_2}{\sqrt{r_1 r_2}}$$

Based on 4) $\delta = \frac{2\pi}{\lambda_{\text{cav}}} (2n_{\text{cav}}L_{\text{cav}} \cos\theta_i) = 2\pi P, \quad \cos\theta_i = 1$

(L_{cav} is large enough that $\phi(E)$ is neglected) (normal incidence)

$$\Rightarrow |\Delta\delta| = \frac{4\pi n_{\text{cav}} L_{\text{cav}}}{\lambda_{\text{cav}}^2} \Delta\lambda_{\text{cav}} = \frac{4\pi n_{\text{cav}} L_{\text{cav}}}{\lambda_{\text{cav}}} \cdot \frac{\Delta\lambda_{\text{cav}}}{\lambda_{\text{cav}}} = \frac{2\pi P}{Q}$$

where $Q = \frac{\lambda_{\text{cav}}}{\Delta\lambda_{\text{cav}}}$ is the quality factor of the Fabry-Perot cavity, also known as the resolving power.

At the limit of resolution, we fulfill the equality: $2\varepsilon = |\Delta\delta|$

By definition, $\gamma_c = \Delta\omega = \Delta\left(\frac{2\pi c}{\lambda}\right) = 2\pi c \frac{\Delta\lambda_{\text{cav}}}{\lambda_{\text{cav}}^2}$

$$= 2\pi c \frac{|\Delta\delta|}{4\pi n_{\text{cav}} L_{\text{cav}}} = \frac{c \cdot \varepsilon}{n_{\text{cav}} L_{\text{cav}}}$$

$$\Rightarrow \gamma_c = \frac{c(1-r_1 r_2)}{n_{\text{cav}} L_{\text{cav}} \sqrt{r_1 r_2}}$$

6) Adjacent modes being separated by $2\pi \Rightarrow F = \frac{2\pi}{2\varepsilon}$

$$\Rightarrow F = \frac{\pi \sqrt{r_1 r_2}}{1 - r_1 r_2}$$

7) • $\vec{k} = \vec{k}_{||} + \vec{k}_z$ and the cavity photon energy is such that:

$$\vec{k}_{||}^2 + \vec{k}_z^2 = \left(\frac{2\pi n_{\text{cav}}}{\lambda}\right)^2$$

• under normal incidence: $\theta = \theta_i = 0$, which implies that:

$$k_z = \frac{P\pi}{L_{\text{cav}}}$$

• and the dispersion of optical modes is then given by:

$$E_c(\vec{k}_{||}) = \frac{\hbar c P\pi}{n_{\text{cav}} L_{\text{cav}}} \left(1 + \left(\frac{L_{\text{cav}} k_{||}}{P\pi}\right)^2\right)^{1/2}$$

8) For small $\vec{k}_{||}$ values: $E_c(\vec{k}_{||}) \approx \frac{\hbar c p \pi}{n_{cav} L_{cav}} \left(1 + \frac{L_{cav}^2 k_{||}^2}{2 p^2 \pi^2} \right)$

Thus, $E_c(\vec{k}_{||}) = \frac{\hbar c p \pi}{n_{cav} L_{cav}} + \frac{\hbar c p \pi L_{cav}^2 k_{||}^2}{n_{cav} L_{cav} 2 p^2 \pi^2}$

$\Rightarrow E_c(\vec{k}_{||}) = E_c(0) + \frac{\hbar c L_{cav}}{2 n_{cav} p \pi} \vec{k}_{||}^2$ with $E_c(0) = \frac{\hbar c p \pi}{n_{cav} L_{cav}}$

and finally: $E_c(\vec{k}_{||}) = E_c(0) + \frac{\hbar^2 \vec{k}_{||}^2}{2 m_{ph}}$ with $m_{ph} = \frac{\hbar p \pi n_{cav}}{c L_{cav}}$

9) If one considers the penetration length L_{DBR} and $\lambda_{DBR} \approx \lambda_{cav} \approx \lambda$:

$$L_{cav} + 2 L_{DBR} \approx \frac{p \lambda}{2 n_{cav}} + 2 \cdot \frac{\lambda}{2} \frac{n_2}{2 \tilde{n} \Delta n}$$

$$\approx \frac{p \lambda}{2 n_{cav}} + \frac{\lambda}{2 n_{cav}} \frac{n_{cav} n_2}{\Delta n \tilde{n}} \sim \frac{n_{cav}}{\Delta n} \lambda$$

$\Rightarrow 2 n_{cav} (L_{cav} + 2 L_{DBR}) \approx \underbrace{\left(p + \frac{n_{cav}}{\Delta n} \right)}_{P_{eff}} \lambda$
 P_{eff} ... effective order of the cavity

$\Rightarrow \gamma_c = \frac{c}{n_{cav} (L_{cav} + 2 L_{DBR})} \frac{1 - r_1 r_2}{\sqrt{r_1 r_2}}$

10) a) SiO₂/Si₃N₄

The SiO₂/Si₃N₄ couple is made of **amorphous** materials characterized by a **wide bandgap** (insulating materials). They are therefore well adapted to cover a wide spectral range (from the IR down to the UV ($\lambda \sim 300\text{nm}$)). In addition, costs associated with their deposition are low compared with crystalline semiconductor epitaxy techniques (use of low temperature ($T < 300^\circ\text{C}$)).

plasma enhanced chemical vapor deposition))

However, such a system cannot be used as a bottom DBR if we wish to realize a crystalline semiconductor microcavity (MC) unless wafer bonding techniques are employed to couple such a DBR to the cavity but it will involve lengthy processing steps to remove the DBR substrate.
(need for clean room facilities)

b) AlAs/GaAs

The AlAs/GaAs couple is a nearly **strain-free** system as the two materials possess relatively similar lattice parameters so that crack-free DBRs with a high number of pairs and a peak reflectivity $\sim 100\%$ can be obtained (while having a reduced dislocation density).

In addition, it is possible to oxidize the AlAs layers and therefore to have an oxide, AlO_x , which exhibits an optical refractive index much smaller than AlAs. As a result, AlAs/GaAs DBRs are characterized by a **large stopband** and can reach **high reflectivities with a reduced number of pairs**.

Such a couple is used to fabricate GaAs-based VCSELs emitting in the near IR. Due to the **bandgap** of GaAs, it is **not adapted for $\lambda < 830\text{nm}$** .

c) AlN/GaN

The AlN/GaN couple exhibits a **fairly large refractive index contrast** so that a priori a few number of pairs is required to get high reflectivity DBRs. However, contrary to its As-counterpart, the present couple is characterized by a **significant lattice parameter mismatch** which can lead to cracked structures and a high density of dislocations.

Usually the AlGaN/GaN system is preferred but it requires a much larger number of pairs due to the reduced optical refractive index contrast.

Alternatively, the AlInN/GaN system which is perfectly lattice matched for an indium content $x_{\text{In}} \sim 18\%$ can also be used, but the AlInN alloy is difficult to grow.